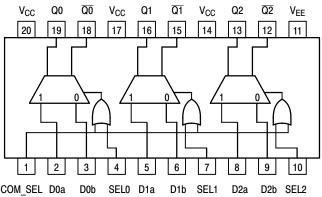
5V ECL Triple 2:1 Multiplexer

The MC100EL59 is a triple 2:1 multiplexer with differential outputs. The output data of the multiplexers can be controlled individually via the select inputs or as a group via the common select input. The flexible selection scheme makes the device useful for both data path and random logic applications.

- Individual or Common Select Controls
- 500 ps Typical Propagation Delays
- ESD Protection: >2 KV HBM
- The 100 Series Contains Temperature Compensation
- PECL Mode Operating Range: V_{CC}= 4.2 V to 5.7 V with V_{EE}= 0 V
- NECL Mode Operating Range: $V_{CC}=0$ V with $V_{EE}=-4.2$ V to -5.7 V
- Internal Input Pulldown Resistors
- Q Output will Default LOW with Inputs Open or at V_{EE}
- Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test
- Moisture Sensitivity Level 1 For Additional Information, see Application Note AND8003/D
- Flammability Rating: UL–94 code V–0 @ 1/8", Oxygen Index 28 to 34
- Transistor Count = 182 devices

Logic Diagram and Pinout: 20-Lead SOIC (Top View)



Warning: All V_{CC} and V_{EE} pins must be externally connected to Power Supply to guarantee proper operation.

PIN DESCRIPTION

Pins	Function
D0a–D2a	ECL Input Data a*
D0b–D2b	ECL Input Data b*
SEL0-SEL2	ECL Individual Select Input*
COM_SEL	ECL Common Select Input*
Q0–Q2; <u>Q0</u> – <u>Q2</u>	ECL Differential Outputs
V _{CC}	Positive Supply
V _{EE}	Negative Supply

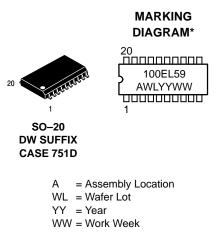
TRUTH TABLE					
SEL*	Data				
H L	a b				

* Pins will default low when left open.



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*For additional information, see Application Note AND8002/D

ORDERING INFORMATION

Device	Package	Shipping		
MC100EL59DW	SO–20	38 Units/Rail		
MC100EL59DWR2	SO-20	1000 Units/Reel		

MAXIMUM RATINGS (Note 1.)

Symbol	Parameter	Condition 1	Condition 2	Rating	Units
V _{CC}	PECL Mode Power Supply	V _{EE} = 0 V		8 to 0	V
V_{EE}	NECL Mode Power Supply	$V_{CC} = 0 V$		8 to 0	V
VI	PECL Mode Input Voltage NECL Mode Input Voltage	V _{EE} = 0 V V _{CC} = 0 V	$\begin{array}{l} V_{I} \leq V_{CC} \\ V_{I} \geq V_{EE} \end{array}$	6 to 0 6 to 0	V V
l _{out}	Output Current	Continuous Surge		50 100	mA mA
ТА	Operating Temperature Range			-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction to Ambient)	0 LFPM 500 LFPM	20 SOIC 20 SOIC	90 60	°C/W °C/W
θ_{JC}	Thermal Resistance (Junction to Case)	std bd	20 SOIC	30 to 35	°C/W
T _{sol}	Wave Solder	<2 to 3 sec @ 248°C		265	°C

1. Maximum Ratings are those values beyond which device damage may occur.

PECL DC CHARACTERISTICS V_{CC}= 5.0 V; V_{EE}= 0.0 V (Note 1)

		–40°C		25°C			85°C				
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{EE}	Power Supply Current		27	32		27	32		27	32	mA
V _{OH}	Output HIGH Voltage (Note 2.)	3915	3995	4120	3975	4045	4120	3975	4050	4120	mV
V _{OL}	Output LOW Voltage (Note 2.)	3170	3305	3445	3190	3295	3380	3190	3295	3380	mV
V _{IH}	Input HIGH Voltage	3835		4120	3835		4120	3835		4120	mV
V _{IL}	Input LOW Voltage	3190		3525	3190		3525	3190		3525	mV
I _{IH}	Input HIGH Current			150			150			150	μΑ
IIL	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: Devices are designed to meet the DC specifications shown in the above table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 lfpm is maintained. 1. Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary +0.8 V / -0.5 V.

2. Outputs are terminated through a 50 ohm resistor to V_{CC}-2 volts.

NECL DC CHARACTERISTICS V_{CC}= 0.0 V; V_{EE}= -5.0 V (Note 1.)

		−40°C		25°C			85°C				
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{EE}	Power Supply Current		27	32		27	32		27	32	mA
V _{OH}	Output HIGH Voltage (Note 2.)	-1085	-1005	-880	-1025	-955	-880	-1025	-955	-880	mV
V _{OL}	Output LOW Voltage (Note 2.)	-1830	-1695	-1555	-1810	-1705	-1620	-1810	-1705	-1620	mV
V _{IH}	Input HIGH Voltage	-1165		-880	-1165		-880	-1165		-880	mV
V _{IL}	Input LOW Voltage	-1810		-1475	-1810		-1475	-1810		-1475	mV
I _{IH}	Input HIGH Current			150			150			150	μA
IIL	Input LOW Current	0.5			0.5			0.5			μA

NOTE: Devices are designed to meet the DC specifications shown in the above table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 lfpm is maintained.
Input and output parameters vary 1:1 with V_{CC}. V_{EE} can vary +0.8 V / -0.5 V.
Outputs are terminated through a 50 ohm resistor to V_{CC}-2 volts.

			−40°C			25°C			85°C			
Symbol	Char	acteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f _{max}	Maximum Toggle	Frequency		TBD			TBD			TBD		GHz
t _{PLH} t _{PHL}	Propagation Delay	DATA to Q/Q SEL to Q/Q COM_SEL to Q/Q	340 340 340		690 690 690	340 340 340		690 690 690	340 340 340		690 690 690	ps
t _{skew}	Output–Output S	kew Any D _n , D _m to Q			100			100			100	ps
t _{JITTER}	Cycle-to-Cycle J	litter		TBD			TBD			TBD		ps
t _r t _f	Output Rise/Fall (20% – 80%)		200		540	200		540	200		540	ps

AC CHARACTERISTICS $V_{CC}\text{=}~5.0~\text{V};~V_{EE}\text{=}~0.0~\text{V}~\text{or}~~V_{CC}\text{=}~0.0~\text{V};~V_{EE}\text{=}~-5.0~\text{V}~\text{(Note 1.)}$

1. V_{EE} can vary +0.8 V / -0.5 V.

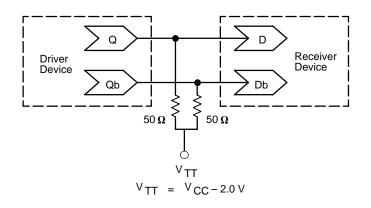
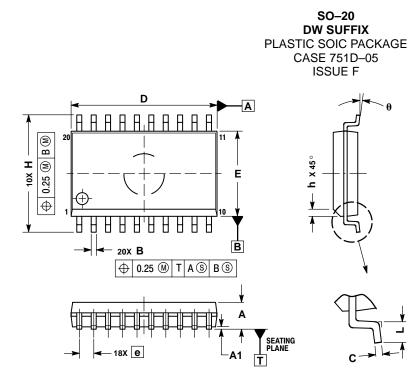


Figure 1. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020 – Termination of ECL Logic Devices.)

Resource Reference of Application Notes

AN1404	_	ECLinPS Circuit Performance at Non–Standard V_{IH} Levels
AN1405	_	ECL Clock Distribution Techniques
AN1406	_	Designing with PECL (ECL at +5.0 V)
AN1503	_	ECLinPS I/O SPICE Modeling Kit
AN1504	_	Metastability and the ECLinPS Family
AN1560	_	Low Voltage ECLinPS SPICE Modeling Kit
AN1568	_	Interfacing Between LVDS and ECL
AN1596	_	ECLinPS Lite Translator ELT Family SPICE I/O Model Kit
AN1650	_	Using Wire–OR Ties in ECLinPS Designs
AN1672	_	The ECL Translator Guide
AND8001	_	Odd Number Counters Design
AND8002	_	Marking and Date Codes
AND8020	_	Termination of ECL Logic Devices

PACKAGE DIMENSIONS



NOTES

- 1. DIMENSIONS ARE IN MILLIMETERS. 2. INTERPRET DIMENSIONS
- INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSION
- MAXIMUM MOLD PROTRUSION 0.15 PER SIDE. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL
- BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS								
DIM	MIN	MAX							
Α	2.35	2.65							
A1	0.10	0.25							
В	0.35	0.49							
С	0.23	0.32							
D	12.65	12.95							
Е	7.40	7.60							
е	1.27	BSC							
Н	10.05	10.55							
h	0.25	0.75							
L	0.50	0.90							
θ	0 °	7 °							

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